

**Vishay Siliconix** 

# Low-Voltage Single SPDT Analog Switch

### DESCRIPTION

The DG2012 is a single-pole/double-throw monolithic CMOS analog switch designed for high performance switching of analog signals. Combining low power, high speed ( $t_{ON}$ : 17 ns,  $t_{OFF}$ : 13 ns), low on-resistance ( $r_{DS(on)}$ : 1  $\Omega$ ) and small physical size (SC70), the DG2012 is ideal for portable and battery powered applications requiring high performance and efficient use of board space.

The DG2012 is built on Vishay Siliconix's low voltage submicron CMOS process. An epitaxial layer prevents latchup. Break-before -make is guaranteed for DG2012.

Each switch conducts equally well in both directions when on, and blocks up to the power supply level when off.

### FEATURES

- Low Voltage Operation (1.8 V to 5.5 V)
- Low On-Resistance r<sub>DS(on)</sub>: 1 Ω Typ.
- Fast Switching t<sub>ON</sub>: 17 ns, t<sub>OFF</sub>: 13 ns
- Low Leakage
- TTL/CMOS Compatible
- 6-Pin SC-70 Package

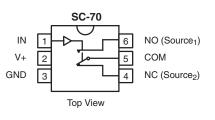
#### BENEFITS

- Reduced Power Consumption
- Simple Logic Interface
- High Accuracy
- Reduce Board Space

#### **APPLICATIONS**

- Cellular Phones
- Communication Systems
- Portable Test Equipment
- · Battery Operated Systems
- Sample and Hold Circuits

#### FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION



Device Marking: E7xx

TRUTH TABLE					
Logic	NC	NO			
0	ON	OFF			
1	OFF	ON			

ORDERING INFORMATION						
Temp Range	Package	Part Number				
- 40 to 85 °C	SC70-6	DG2012DL-T1 DG2012DL-T1-E3				

\* Pb containing terminations are not RoHS compliant, exemptions may apply



RoHS

COMPLIANT

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ABSOLUTE MAXIMUM RATINGS						
Parameter	Limit	Unit				
Referenced V+ to GND	- 0.3 to + 6	v				
IN, COM, NC, NO <sup>a</sup>	- 0.3 to (V+ + 0.3)	v				
Continuous Current (NO, NC and COM	± 100	٣A				
Peak Current (Pulsed at 1 ms, 10 % du	± 300	– mA				
Storage Temperature (D Suffix)		- 65 to 150	°C			
Power Dissipation (Packages) <sup>b</sup>	6-Pin SO70 <sup>c</sup>	250	mW			

Notes:

a. Signals on NC, NO, or COM or IN exceeding V+ will be clamped by internal diodes. Limit forward diode current to maximum current ratings.

b. All leads welded or soldered to PC Board.

c. Derate 3.1 mW/°C above 70 °C.

Parameter		Test Conditions Otherwise Unless Specified		Limits - 40 to 85 °C			
	Symbol	V+ = 2.0 V, $\pm$ 10 %, V <sub>IN</sub> = 0.4 or 1.6 V <sup>e</sup>	Temp <sup>a</sup>	Min <sup>b</sup>	Тур <sup>с</sup>	Max <sup>b</sup>	Unit
Analog Switch							
Analog Signal Range <sup>d</sup>	V <sub>NO</sub> , V <sub>NC</sub> V <sub>COM</sub>		Full	0		V+	v
On-Resistance	r <sub>ON</sub>	V+ = 1.8 V, V <sub>COM</sub> = 0.2 V/0.9 V I <sub>NO</sub> , I <sub>NC</sub> = 10 mA	Room Full <sup>d</sup>		2.7 2.7	5.3 5.3	
r <sub>ON</sub> Flatness <sup>d</sup>	r <sub>ON</sub> Flatness	V+ = 1.8 V, V <sub>COM</sub> = 0 to V+, I <sub>NO</sub> , I <sub>NC</sub> = 10 mA	Room			3	Ω
r <sub>ON</sub> Match <sup>d</sup>	$\Delta r_{ON}$		Room			0.25	
Quiteborg Landson Quart	I <sub>NO(off)</sub> I <sub>NC(off)</sub>	V+ = 2.2 V	Room Full	- 0.5 - 5.0		0.5 5.0	
Switch Off Leakage Current <sup>f</sup>	$V_{\rm NO}, V_{\rm NC} = 0.5 \text{ V}/1.5 \text{ V}, V_{\rm COM} = 1.5 \text{ V}/0.5 \text{ V}$	Room Full <sup>d</sup>	- 0.5 - 5.0		0.5 5.0	nA	
Channel-On Leakage Current <sup>f</sup>	I <sub>COM(on)</sub>	$V_{+} = 22 V V_{NO} = V_{OOV} = (15 V/15 V)$	Room Full <sup>d</sup>	- 0.5 - 5.0		0.5 5.0	
Digital Control							
Input High Voltage	V <sub>INH</sub>		Full	1.6			v
Input Low Voltage	V <sub>INL</sub>		Full			0.4	v
Input Capacitance <sup>d</sup>	C <sub>in</sub>		Full		3		pF
Input Current <sup>f</sup>	$I_{\rm INL}$ or $I_{\rm INH}$	V <sub>IN</sub> = 0 or V+	Full	- 1		1	μA
Dynamic Characteristics					-		_
Turn-On Time <sup>d</sup>	t <sub>ON</sub>		Room Full <sup>d</sup>		43	63 65	
Turn-Off Time <sup>d</sup>	t <sub>OFF</sub>	$V_{NO}$ or $V_{NC}$ = 1.5 V, $R_L$ = 300 $\Omega$ , $C_L$ = 35 pF Figures 1 and 2	Room Full <sup>d</sup>		23	45 46	ns
Break-Before-Make Time <sup>d</sup>	t <sub>d</sub>		Room	2			
Charge Injection <sup>d</sup>	Q <sub>INJ</sub>	$C_L$ = 1 nF, $V_{GEN}$ = 0 V, $R_{GEN}$ = 0 $\Omega$ , Figure 3	Room		7		pC
Off-Isolation <sup>d</sup>	OIRR	$R_1 = 50 \Omega_2 C_1 = 5 pF_1 f = 1 MHz$	Room		- 63		dB
Crosstalk <sup>d</sup>	X <sub>TALK</sub>	$n_{\rm L} = 50.92, C_{\rm L} = 5 \text{ pr}, T = 1 \text{ MHZ}$	Room		- 64		uD
N <sub>O</sub> , N <sub>C</sub> Off Capacitance <sup>d</sup>	C <sub>NO(off)</sub> C <sub>NC(off)</sub>	V <sub>IN</sub> = 0 or V+, f = 1 MHz	Room		22		pF
Channel-On Capacitance <sup>d</sup>	C <sub>ON</sub>		Room		58		1 '



Parameter		Test Conditions Otherwise Unless Specified		Limits - 40 to 85 °C			
	Symbol	V+ = 3 V, $\pm$ 10 %, V <sub>IN</sub> = 0.6 or 2.0 V <sup>e</sup>	Temp <sup>a</sup>	Min <sup>b</sup>	Тур <sup>с</sup>	Max <sup>b</sup>	Unit
Analog Switch	•		•				
Analog Signal Range <sup>d</sup>	V <sub>NO</sub> , V <sub>NC</sub> V <sub>COM</sub>		Full	0		V+	v
On-Resistance	r <sub>ON</sub>	V+ = 2.7 V, V <sub>COM</sub> = 0.2 V/1.5 V, I <sub>NO</sub> $I_{NC}$ = 10 mA	Room Full		1.4 1.6	2.1 2.3	
r <sub>ON</sub> Flatness	r <sub>ON</sub> Flatness	V+ = 2.7 V, V <sub>COM</sub> = 0 to V+, $I_{NO}$ , $I_{NC}$ = 10 mA	Room			0.85	Ω
r <sub>ON</sub> MatchFlat	$\Delta r_{ON}$		Room			0.25	
Switch Off Leakage Current <sup>f</sup>	I <sub>NO(off)</sub> I <sub>NC(off)</sub>	V+ = 3.3 V	Room Full	- 0.5 - 5.0		0.5 5.0	
Switch On Leakage Current	I <sub>COM(off)</sub>	$V_{NO}$ , $V_{NC}$ = 1 V/3 V, $V_{COM}$ = 3 V/1 V	Room Full	- 0.5 - 5.0		0.5 5.0	nA
Channel-On Leakage Current <sup>f</sup>	I <sub>COM(on)</sub>	$V$ + = 3.3 V, $V_{NO}$ , $V_{NC}$ = $V_{COM}$ = 1 V/3 V	Room Full	- 0.5 - 5.0		0.5 5.0	1
Digital Control							
Input High Voltage	V <sub>INH</sub>		Full	2			v
Input Low Voltage	V <sub>INL</sub>		Full			0.6	v
Input Capacitance <sup>d</sup>	C <sub>in</sub>		Full		3		pF
Input Current <sup>f</sup>	I <sub>INL</sub> or I <sub>INH</sub>	V <sub>IN</sub> = 0 or V+	Full	- 1		1	μA
Dynamic Characteristics	•		•				
Turn-On Time	t <sub>ON</sub>		Room Full		27	47 48	
Turn-Off Time	t <sub>OFF</sub>	$V_{NO} \text{ or } V_{NC} = 2.0 \text{ V}, \text{ R}_{L} = 300 \Omega, \text{ C}_{L} = 35 \text{ pF}$ Figures 1 and 2	Room Full		17	37 38	ns
Break-Before-Make Time	t <sub>d</sub>		Room	1			
Charge Injection <sup>d</sup>	Q <sub>INJ</sub>	$C_L$ = 1 nF, $V_{GEN}$ = 0 V, $R_{GEN}$ = 0 $\Omega$ , Figure 3	Room		10		pC
Off-Isolation <sup>d</sup>	OIRR	$B_{1} = 50.0$ C = 5 pE f = 1 MHz	Room		- 63		dD
Crosstalk <sup>d</sup>	X <sub>TALK</sub>	$R_L = 50 \Omega$ , $C_L = 5 pF$ , $f = 1 MHz$	Room		- 64		dB
NO, NC Off Capacitance <sup>d</sup>	C <sub>NO(off)</sub> C <sub>NC(off)</sub>	V <sub>IN</sub> = 0 or V+, f = 1 MHz	Room		21		pF
Channel-On Capacitance <sup>d</sup>	C <sub>ON</sub>	1	Room		57		
Power Supply		•	•				
Power Supply Range	V+			1.8		5.5	V
Power Supply Current	l+	V <sub>IN</sub> = 0 or V+			0.01	1.0	μA

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SPECIFICATIONS (V+ = 5.0 V)							
		Test Conditions Otherwise Unless Specified		Limits - 40 to 85 °C			
Parameter	Symbol	V+ = 5 V, $\pm$ 10 %, V $_{IN}$ = 0.8 or 2.4 V $^{e}$	Temp <sup>a</sup>	Min <sup>b</sup>	Тур <sup>с</sup>	Max <sup>b</sup>	Unit
Analog Switch							
Analog Signal Range <sup>d</sup>	V <sub>NO</sub> , V <sub>NC</sub> V <sub>COM</sub>		Full	0		V+	v
On-Resistance	r <sub>ON</sub>	V+ = 4.5 V, V <sub>COM</sub> = 0.5 V/2.5 V I <sub>NO</sub> , I <sub>NC</sub> = 10 mA	Room Full		1.0 1.2	1.8 1.9	
r <sub>ON</sub> Flatness <sup>d</sup>	r <sub>ON</sub> Flatness	V+ = 4.5 V, V <sub>COM</sub> = 0 to V+, I <sub>NO</sub> , I <sub>NC</sub> = 10 mA	Room			0.55	Ω
r <sub>ON</sub> Match <sup>d</sup>	$\Delta r_{ON}$		Room			0.25	
Switch Off Leakage Current	I <sub>NO(off)</sub> I <sub>NC(off)</sub>	V+ = 5.0 V V <sub>NO</sub> , V <sub>NC</sub> = 0.5 V/4.5 V, V <sub>COM</sub> = 4.5 V/0.5 V	Room Full	- 0.5 - 5.0		0.5 5.0	nA
Switch On Leakage Ourrent	I <sub>COM(off)</sub>		Room Full	- 0.5 - 5.0		0.5 5.0	
Channel-On Leakage Current	I <sub>COM(on)</sub>	V+ = 5.0 V, V <sub>NO</sub> , V <sub>NC</sub> = V <sub>COM</sub> = 0.5 V/4.5 V	Room Full	- 0.5 - 5.0		0.5 5.0	
Digital Control					1	•	r
Input High Voltage	V <sub>INH</sub>		Full	2.4			v
Input Low Voltage	V <sub>INL</sub>		Full			0.8	
Input Capacitance	C <sub>in</sub>		Full		3		pF
Input Current	$I_{\rm INL}$ or $I_{\rm INH}$	V <sub>IN</sub> = 0 or V+	Full	- 1		1	μA
Dynamic Characteristics					1		
Turn-On Time <sup>d</sup>	t <sub>ON</sub>	$V_{NO}$ or $V_{NC}$ = 3 V, R <sub>1</sub> = 300 $\Omega$ , C <sub>1</sub> = 35 pF	Room Full		17	38 39	
Turn-Off Time <sup>d</sup>	t <sub>OFF</sub>	$v_{NO}$ of $v_{NC} = 3$ v, $H_L = 300$ s2, $G_L = 35$ pF Figures 1 and 2	Room Full		13	32 33	ns
Break-Before-Make Time <sup>d</sup>	t <sub>d</sub>		Room	1			
Charge Injection <sup>d</sup>	Q <sub>INJ</sub>	$C_L$ = 1 nF, $V_{GEN}$ = 0 V, $R_{GEN}$ = 0 $\Omega$ , Figure 3	Room		20		рС
Off-Isolation <sup>d</sup>	OIRR	$P_{-}=5000$ $C_{-}=5$ $p_{-}=5$ $MH_{-}$	Room		- 63		40
Crosstalk <sup>d</sup>	X <sub>TALK</sub>	$R_L = 50 $ Ω, $C_L = 5 $ pF, f = 1 MHz	Room		- 64		dB
Source-Off Capacitance <sup>d</sup>	C <sub>NO(off)</sub> C <sub>NC(off)</sub>	V <sub>IN</sub> = 0 or V+, f = 1 MHz	Room		20		pF
Channel-On Capacitance <sup>d</sup>	C <sub>ON</sub>		Room		56		

Notes:

a. Room = 25 °C, Full = as determined by the operating suffix.

b. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.

c. Typical values are for design aid only, not guaranteed nor subject to production testing.

d. Guarantee by design, nor subjected to production test.

e.  $V_{IN}$  = input voltage to perform proper function.

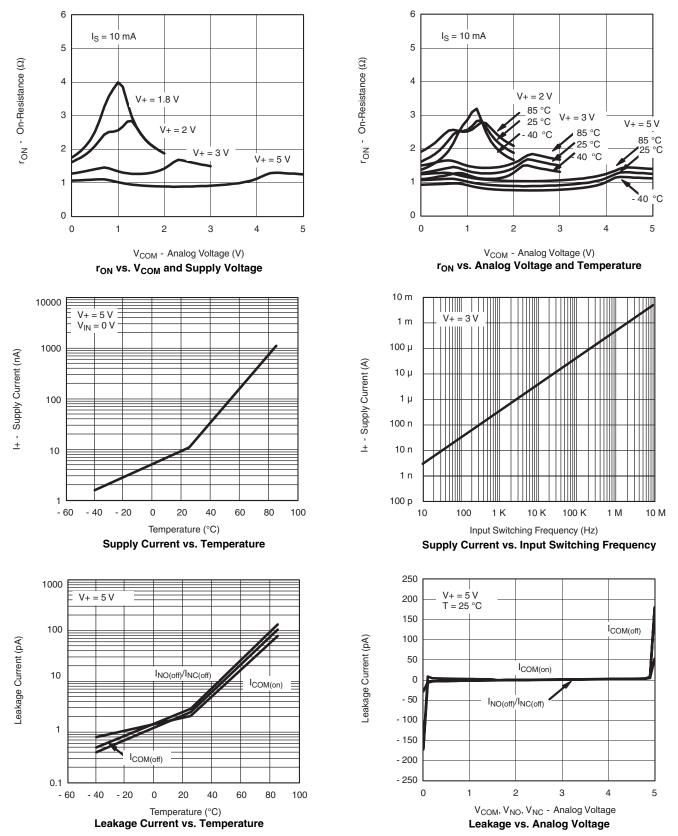
f. Guaranteed by 5 V leakage testing, not production tested.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



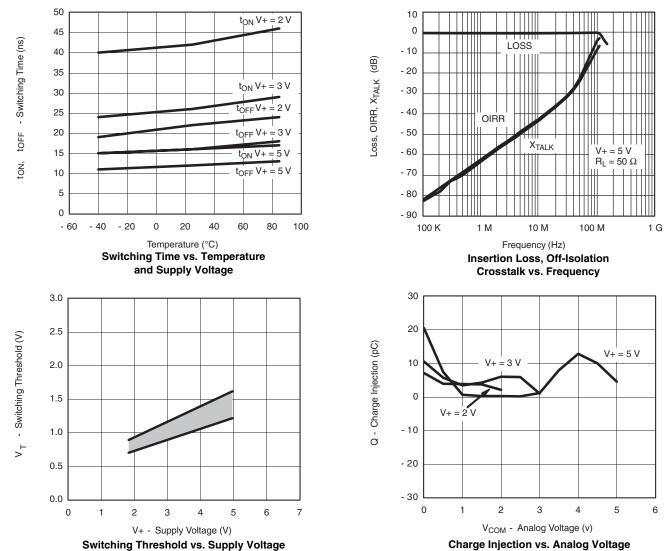
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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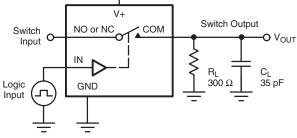


**ISHA** 

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### **TEST CIRCUITS**

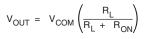
VISHA

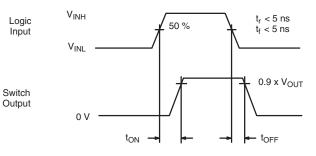


V+

Q

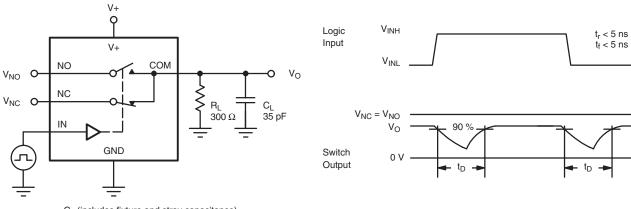
C<sub>L</sub> (includes fixture and stray capacitance)





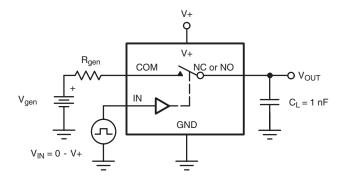
Logic "1" = Switch On Logic input waveforms inverted for switches that have the opposite logic sense.

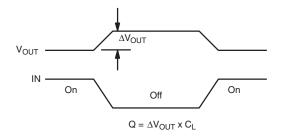




C<sub>L</sub> (includes fixture and stray capacitance)

#### Figure 2. Break-Before-Make Interval





IN depends on switch configuration: input polarity determined by sense of switch.

Figure 3. Charge Injection

### DG2012

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### **TEST CIRCUITS**

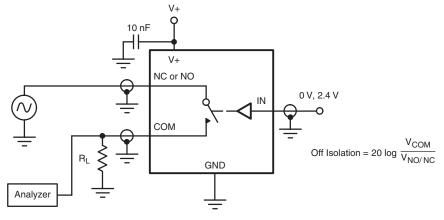


Figure 4. Off-Isolation

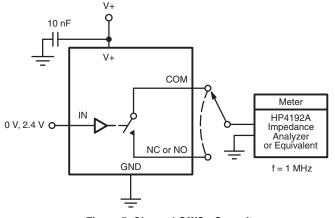


Figure 5. Channel Off/On Capacitance

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